

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10541784	AUFFRET, ERIC
	Examiner	Art Unit
	Nguyen, Hai V	2618

SEARCHED

Class	Subclass	Date	Examiner
455	522	02/19/2008	HN

SEARCH NOTES

Search Notes	Date	Examiner
EAST search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) (See search history printout report)	02/19/2008	HN
EAST search updated	07/14/2008	HN
Interference search (see search history printout report)	07/14/2008	HN

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
455	67.11, 562.1	07/14/2008	HN
370	334	07/14/2008	HN